



# 4-Bit Bidirectional Level Shifter with Automatic Sensing & Ultra Tiny Package

#### **Features**

- High-Speed with 24 Mb/s Data Rate for push-pull applications
- High-Speed with 2 Mb/s Data Rate for open-drain applications
- 1.65V to 3.6V on A Port and 2.3V to 5.5V on B Port
- $V_{CCA}$  must be less than or equal to  $V_{CCB}$
- No Direction-Control Signal Needed
- Low Bit-to-Bit Skew
- Non-preferential Power-up Sequencing
- ESD protection exceeds JESD22-A114
  - A Port: 2500V HBM
  - B Port: 2500V HBM
- Integrated 10 k $\Omega$  Pull-Up Resistors
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/quality/product-definitions/

- Packaging (Pb-free & Green):
  - 14-Pin, TSSOP (L)
  - 14-Pin, 3.5mm x 3.5mm, TQFN (ZB)
  - 12-Pin, 1.7mm x 2.0mm, XQFN (ZMA)
  - 12-Pin, 1.87mm x 1.37mm, WLCSP (GAB)

# Application(s)

- I2C, SMBus, MDIO
- Low Voltage ASIC Level Translation
- Mobile Phones, PDAs, Cameras

# **Description**

The DIODES<sup>TM</sup> LXS0104 is a 4-bit configurable, dual-supply, bidirectional, auto-sensing translator that does not require a directional control pin. The A and B ports are designed to track two different power supply rails,  $V_{\text{CCA}}$  and  $V_{\text{CCB}}$  respectively. This allows bidirectional translation between lower and higher logic signal levels.

When the OE pin is low, all I/Os are configured to be in a high-impedance state.

Power-off protection is implemented to prevent current passing through the device when it is powered-down.

# **Block Diagram**

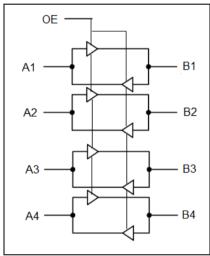


Figure 1: Block Diagram

#### Notes:

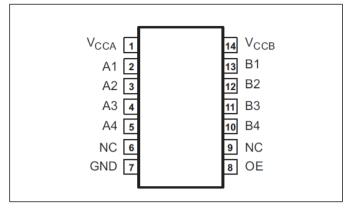
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.





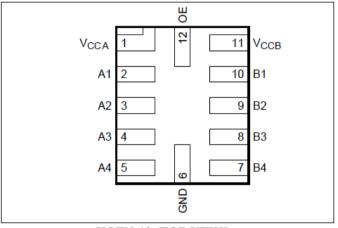
# **Pin Configuration**

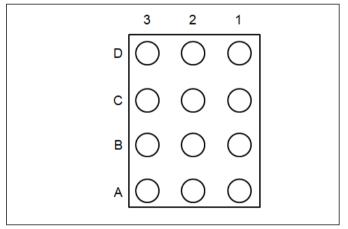


VccB **B1** A2 B2 А3 11 **B**3 Α4 5 В4 10 NC 6 NC GND 

TSSOP-14 (TOP VIEW)

**TQFN-14 (TOP VIEW)** 





**XQFN-12 (TOP VIEW)** 

WLCSP (TOP VIEW)

# **Pin Description**

Pin Name	TSSOP Pin#	TQFN Pin#	XQFN Pin#	WLCSP Pin#	Type	Description
$V_{CCA}$	1	1	1	B2	Power	A-port supply voltage.1.65 V $\leq$ V <sub>CCA</sub> $\leq$ 3.6 V
V <sub>CCB</sub>	14	14	11	A2	Power	B-port supply voltage. $2.3 \text{ V} \le V_{CCB} \le 5.5 \text{ V}$
A1	2	2	2	A3	I/O	Input/output A. Referenced to V <sub>CCA</sub> .
A2	3	3	3	В3	I/O	Input/output A. Referenced to V <sub>CCA</sub>
A3	4	4	4	C3	I/O	Input/output A. Referenced to V <sub>CCA</sub>
A4	5	5	5	D3	I/O	Input/output A. Referenced to V <sub>CCA</sub>
B1	13	13	10	A1	I/O	Input/output B. Referenced to V <sub>CCB</sub>
B2	12	12	9	B1	I/O	Input/output B. Referenced to V <sub>CCB</sub>
В3	11	11	8	C1	I/O	Input/output B. Referenced to V <sub>CCB</sub>
B4	10	10	7	D1	I/O	Input/output B. Referenced to V <sub>CCB</sub>
OE	8	8	12	C2	Input	Output enable (active High). Pull OE low to place all outputs in 3-state mode. Referenced to V <sub>CCA</sub> .
GND	7	7	6	D2	GND	Ground.
NC	6,9	6,9	-	-	-	No Connection







# **Maximum Ratings**

ı		
	Storage Temperature	-65 °C to +150 °C
	DC Supply Voltage port B	-0.5 V to +6.5 V
	DC Supply Voltage port A	0.5 V to +4.6 V
	Vi (A) referenced DC Input Voltage	0.5 V to +4.6 V
	Vi (B) referenced DC Input Voltage	0.5 V to +6.5 V
	Enable Control Pin DC Input Voltage	0.5 V to +4.6 V
	Continuous output current, I/O	45 mA

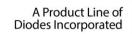
### Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

# **Recommended Operation Conditions**

Symbol	Parameter	Min	Тур	Max	Unit
$V_{CCA}$	V <sub>CCA</sub> Positive DC Supply Voltage	1.65	-	3.6	V
$V_{CCB}$	V <sub>CCB</sub> Positive DC Supply Voltage	2.3	-	5.5	V
$V_{OE}$	Enable Control Pin Voltage	GND	-	3.6	V
V	I/O Pin Voltage (A1, A2, A3, A4)	GND	-	$V_{CCA}$	V
$V_{IO}$	I/O Pin Voltage (B1, B2, B3, B4)	GND	-	$V_{CCB}$	V
	Input transition rise or fall time	-	-	-	-
$\Delta t / \Delta v$	A or B port Push-Pull Driving, $(V_{CCA} = 1.65 \text{ V to } 3.6 \text{ V}, V_{CCB} = 2.3 \text{ V to } 5.5 \text{ V})$	-	-	10	ns/V
	OE ( $V_{CCA} = 1.65 \text{ V}$ to 3.6 V, $V_{CCB} = 2.3 \text{ V}$ to 5.5 V)	-	-	10	ns/V
$T_A$	Operating Temperature Range	-40	-	+85	°C





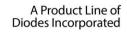


# **DC Electrical Characteristics**

Vccı is the supply voltage associated with the input port. Vcco is the supply voltage associated with the output port.

Symbol	Parameter	Test Conditions	V <sub>CCA</sub>	$V_{CCB}$	Temp.	Min	Тур	Max	Unit
$V_{\mathrm{IHB}}$	B port Input HIGH Voltage	$I_{OHA} = -20 \text{ uA}$ $V_{IA} = V_{CCA} \times 0.67$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	V <sub>CCI</sub> – 0.4	-	-	V
$V_{\rm ILB}$	B port Input LOW Voltage	$\begin{split} I_{OLA} &= 1 \ mA \\ V_{IA} &= 0.4 \ V \end{split}$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	-	-	0.15	V
$V_{\mathrm{IHA}}$	A port Input HIGH	I <sub>OHB</sub> = -20 uA	1.65 V to 1.95 V	2.3 V to 5.5 V	-40 to 85 ℃	V <sub>CCI</sub> – 0.2		-	V
V IHA	Voltage	$V_{IB} = V_{CCB} \times 0.67$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 C	V <sub>CCI</sub> – 0.4	_	•	V
$V_{\rm ILA}$	A port Input LOW Voltage	$\begin{split} I_{OLB} &= 1 \text{ mA} \\ V_{IB} &= 0.4 \text{ V} \end{split}$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 °C	-	-	0.15	V
$V_{\mathrm{IH}}$	Control Pin Input HIGH Voltage	-	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 °C	V <sub>CCA</sub> x 0.65	-	-	V
$V_{\rm IL}$	Control Pin Input LOW Voltage	-	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	-	-	V <sub>CCA</sub> x 0.35	V
$V_{\mathrm{OHB}}$	B port Output HIGH Voltage	$I_{OHB} = -20 \text{ uA}$ $V_{IA} \ge V_{CCA} - 0.4 \text{ V}$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	0.8 x Vссв	-	-	V
$V_{\mathrm{OLB}}$	B port Output LOW Voltage	$I_{OLB} = 1 \text{ mA}$ $V_{IA} \le 0.15 \text{ V}$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	-	-	0.4	V
$V_{\mathrm{OHA}}$	A port Output HIGH Voltage	$\begin{split} I_{OHA} &= \text{-}20 \text{ uA} \\ V_{IB} &\geq V_{CCB} - 0.4 \text{ V} \end{split}$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	0.8 * Vcca	-	1	V
$V_{\text{OLA}}$	A port Output LOW Voltage	$\begin{split} I_{\text{OLA}} &= 1 \text{ mA} \\ V_{\text{IB}} &\leq 0.15 \text{ V} \end{split}$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 ℃	-	-	0.4	V
$I_{\rm I}$	Input leakage	OE, $V_I = V_{CCI}$ or	1.65 V to	2.3 V to	25 ℃	-	-	±1	μA
11	current	GND	3.6 V	5.5 V	-40 to 85 °C	-	-	±2	μΑ
		Amout	0 V	0 V to	25 ℃	-	-	±1	
T	Partial power	A port	0 <b>v</b>	5.5 V	-40 to 85 °C	-	-	±2	^
IOFF	I <sub>OFF</sub> down current	Dnort	0 V to	0 V	25 ℃	-	-	±1	μΑ
		B port	3.6 V	0 <b>v</b>	-40 to 85 °C	-	-	±2	
T	Off-state	A D OF H	1.65 V to	2.3 V to	25 ℃	-	-	±1	
$I_{OZ}$	Leakage current	A or B port, $OE = V_{IL}$	3.6 V	5.5 V	-40 to 85 ℃	-	-	±2	μA
T.	V <sub>CCA</sub> Supply		1.65 V to 3.6	2.3 V to 5.5 V	-40 to 85 ℃	-	-	2.8	
$I_{QVCCA}$	Current	$V_I = V_O = open, I_O = 0$	3.6 V	0 V	-40 to 85 °C	-	-	2.2	μA
			0 V	5.5 V	-40 to 85 °C	-	-	-1	







# DC Electrical Characteristics Cont.

Symbol	Parameter	<b>Test Conditions</b>	VCCA	V <sub>CCB</sub>	Temp.	Min	Тур	Max	Unit
	V <sub>CCB</sub> Supply	$V_I = V_O = open, I_O =$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 °C	-	-	12	-
IQVCCB	Current	0	3.6 V	0 V	-40 to 85 °C	-	1	-1	μA
			0 V	5.5 V	-40 to 85 °C	-	-	1	-
I <sub>QVCCA</sub> + I <sub>QVCCB</sub>	Total Supply current	$V_I = V_O = open, I_O = 0$	1.65 V to 3.6 V	2.3 V to 5.5 V	-40 to 85 °C	-	-	14.4	μΑ
$C_{\mathrm{I}}$	Input	2231	2231	25 ℃	-	2.5	-	F	
$C_{\rm I}$	Capacitance	OE	3.3 V	3.3 V	-40 to 85 °C	-	-	4.8	pF
		A D	3.3 V	2231	25 ℃	-	12	-	
		A or B port	3.3 V	3.3 V	-40 to 85 ℃	-	-	15	
C	Input-to-		0.1/	0.1/	25 ℃	-	5	6.5	
C <sub>IO</sub>	Capacitance	A port	0 V	0 V	-40 to 85 °C	-	-	7.5	pF
			0.17	0.1/	25 ℃	-	6	7.5	
		B port	UV	0 V 0 V	-40 to 85 ℃	-	-	8.5	

# **AC Electrical Characteristics**

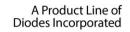
(Unless otherwise specified, -40  $^{\circ}$ C  $\leq$  T<sub>A</sub> $\leq$  85  $^{\circ}$ C)

I/O test circuits of Figures 2, 3, 4 & 5,  $C_{LOAD}$  = 15 pF,  $R_{LOAD}$  = 1 M $\Omega$ , input pulse generator having the following characteristics:  $Z_0$  = 50  $\Omega$ ,  $PRR \le 10$  MHz,  $dv/dt \ge 1$  V / ns

 $V_{CCA}$ = 1.8 V ± 0.15 V

Combal	D (	Tost Conditions	$V_{CCB} = 2.5$	$V \pm 0.2 V$	$V_{CCB} = 3.3$	3 V ± 0.3 V	$V_{CCB} = 5.0$	V ± 0.5 V	T 124
Symbol	Parameter	Test Conditions	Min	Max	Min	Max	Min	Max	Unit
+	High to Low	Push-pull driving	-	5.3	-	5.4	-	6.8	
t <sub>PHL-A-B</sub>	propagation delay	Open-Drain driving	-	8.8	-	9.6	-	10	ns
	Low to High	Push-pull driving	-	6.8	-	7.1	-	7.5	
t <sub>PLH-A-B</sub>	propagation delay	Open-Drain driving	-	260	-	208	-	198	ns
<b>t</b>	High to Low	Push-pull driving	-	4.4	-	4.5	-	4.7	
t <sub>PHL-B-A</sub>	propagation delay	Open-Drain driving	-	5.3	-	4.4	-	4	ns
+	Low to High	Push-pull driving	-	5.3	-	4.5	-	0.5	
t <sub>PLH-B-A</sub>	propagation delay	Open-Drain driving	-	175	-	140	-	102	ns
ten	Enable Time	OE to A or B	-	200	-	200	-	200	ns
tdis	Disable Time	OE to A or B	-	230	-	230	-	230	ns
,		Push-pull driving	3.2	9.5	2.3	9.3	2.7	7.6	
$t_{RA}$	A port Rise Time	Open-Drain driving	32.8	165	27.9	132	20.5	95	ns
	D (D) III	Push-pull driving	2.8	10.8	2.7	9.1	2.1	7.6	
$t_{RB}$	B port Rise Time	Open-Drain driving	30	145	23	106	10	58	ns
		Push-pull driving	2	5.9	1.9	6	1.7	13.3	
$t_{FA}$	A port Fall Time	Open-Drain driving	3	6.9	3	6.4	3.1	6.1	ns
	D . E 11 E	Push-pull driving	2.9	13.8	2.8	16.2	2.8	16.2	
$t_{FB}$	B port Fall Time	Open-Drain driving	3.1	13.8	3.2	16.2	3.9	16.2	ns
t <sub>PPSKEW</sub>	Channel-to-Channel Skew	-	-	0.7	-	0.7	-	0.7	ns
£	M : D : D :	Push-pull driving	21	-	22	-	24	-	Mha
fdata	Maximum Data Rate	Open-Drain driving	2	-	2	-	2	-	Mbps







 $V_{CCA}$ = 2.5 V± 0.2 V

Cl1	<b>.</b>	T4 C 122	$V_{CCB} = 2.5$	$V \pm 0.2 V$	$V_{CCB} = 3.3$	3V ± 0.3 V	$V_{CCB} = 5.0$	V ± 0.5 V	TT 24
Symbol	Parameter	Test Conditions	Min	Max	Min	Max	Min	Max	Unit
	High to Low	Push-pull driving	-	3.2	-	3.7	-	3.8	
$t_{PHL-A-B}$	propagation delay	Open-Drain driving	-	6.3	-	6	-	5.8	ns
t	Low to High	Push-pull driving	-	3.5	-	4.1	-	4.4	
t <sub>PLH-A-B</sub>	propagation delay	Open-Drain driving	-	250	-	206	-	190	ns
t	High to Low	Push-pull driving	-	3	-	3.6	-	4.3	
t <sub>PHL-B-A</sub>	propagation delay	Open-Drain driving	-	4.7	-	4.2	-	4	ns
+	Low to High	Push-pull driving	-	3.4	-	1.6	-	1	
t <sub>PLH-B-A</sub>	propagation delay	Open-Drain driving	-	170	-	140	-	103	ns
ten	Enable Time	OE to A or B	-	200	-	200	-	200	ns
tdis	Disable Time	OE to A or B	-	50	-	40	-	35	ns
	. D. T.	Push-pull driving	2.8	7.4	2.6	6.6	1.8	5.6	
$t_{RA}$	A port Rise Time	Open-Drain driving	24.9	149	22.8	121	18.4	89	ns
	D . D' T'	Push-pull driving	2.7	8.3	2.4	7.2	2	6.1	
$t_{RB}$	B port Rise Time	Open-Drain driving	25.5	151	20.5	112	12	64	ns
+	A (E.11/E)	Push-pull driving	1.9	5.7	1.9	5.5	1.8	5.3	
$t_{FA}$	A port Fall Time	Open-Drain driving	2.9	6.9	2.9	6.2	2.9	5.8	ns
	D . E !! E!	Push-pull driving	2.2	7.8	2.4	6.7	2.6	6.6	
$t_{FB}$	B port Fall Time	Open-Drain driving	3	8.8	2.9	9.4	3.1	10.4	ns
t <sub>PPSKEW</sub>	Channel-to-Channel Skew	-	-	0.7	-	0.7	-	0.7	ns
£	Maximum Data	Push-pull driving	20	-	22	-	24	-	Mhn
$f_{DATA}$	Rate	Open-Drain driving	2	-	2	-	2	-	Mbps





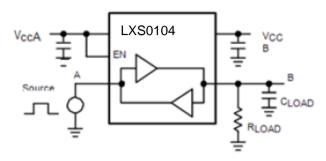


# $V_{CCA}$ = 3.3 V $\pm$ 0.3 V

G 1.1		T 4 C 1141	$V_{CCB} = 3$ .	3 V ± 0.3 V	$V_{CCB} = 5.0$	V ± 0.5 V	TT 14
Symbol	Parameter Test Conditions		Min	Max	Min	Max	Unit
+	High to Low	Push-pull driving	-	2.4	-	3.1	
t <sub>PHL-A-B</sub>	propagation delay	Open-Drain driving	-	4.2	-	4.6	ns
t	Low to High	Push-pull driving	-	4.2	-	4.4	na
t <sub>PLH-A-B</sub>	propagation delay	Open-Drain driving	-	204	-	165	ns
t	High to Low	Push-pull driving	-	2.5	-	3.3	
t <sub>PHL-B-A</sub>	propagation delay	Open-Drain driving	-	124	-	97	ns
+	Low to High	Push-pull driving	-	2.5	-	2.6	
t <sub>PLH-B-A</sub>	propagation delay	Open-Drain driving	-	139	-	105	ns
ten	Enable Time	OE to A or B	-	200	-	200	ns
tdis	Disable Time	OE to A or B	-	230	-	230	ns
	A . D' T'	Push-pull driving	2.3	5.6	1.9	4.8	
$t_{RA}$	A port Rise Time	Open-Drain driving	17.4	116	15.4	85	ns
+	D (D' T'	Push-pull driving	2.5	6.4	2.1	7.4	
$t_{RB}$	B port Rise Time	Open-Drain driving	17.7	116	11.8	72	ns
	A CHE	Push-pull driving	2	5.4	1.9	5	
$t_{FA}$	A port Fall Time	Open-Drain driving	2.8	6.1	2.8	5.7	ns
+	D (E 11 E	Push-pull driving	2.3	7.4	2.4	7.6	
$t_{ m FB}$	B port Fall Time	Open-Drain driving	2.8	7.6	2.9	8.3	ns
t <sub>PPSKEW</sub>	Channel-to-Channel Skew	-	-	0.7	-	0.7	ns
£	Maximum Data	Push-pull driving	23	-	24	-	Mhas
$f_{DATA}$	Rate	Open-Drain driving	2	-	2	-	Mbps



# **Test Circuits**



VCCA LXS0104

LXS0104

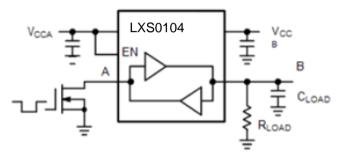
VCCB

RLOAD

Source

Figure 2: Rail-to-Rail Driving A

Figure 3: Rail-to-Rail Driving B



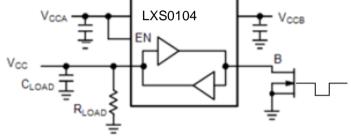
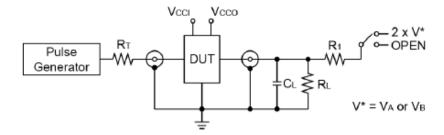


Figure 4: Open-Drain Driving A

Figure 5: Open-Drain Driving B





Test	Switch
t <sub>PZH</sub> , t <sub>PHZ</sub>	Open
t <sub>PZL</sub> , t <sub>PLZ</sub>	2 x V*

 $C_L = 15pF$ 

 $R_L = R_1 = 50k\Omega$ 

 $R_T = Z_{OUT}$  of pulse generator (Typically 50 $\Omega$ )  $V^* = V_A$  or  $V_B$  for A or B measurements, respectively.

Figure 6: Test Circuit for Enable/Disable Time Measurement

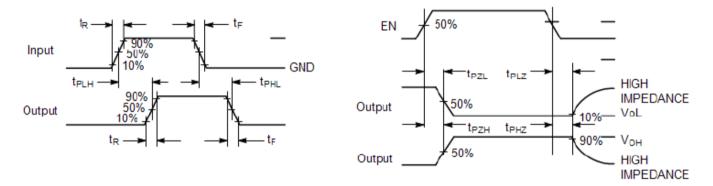
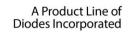


Figure 7: Timing Definitions for Propagation Delays and Enable/Disable Measurement







# **Functional Description**

#### **Level Translator Architecture**

The LXS0104 is a 4-bit configurable, dual-supply, bidirectional, auto-sensing translator that does not require a directional control pin. The A port operating voltage range is from 1.65 V to 3.6 V, and the B port operating voltage range is from 2.3 V to 5.5 V.

The translator has integrated a 10 k $\Omega$  pull–up resistor on each I/O line. The integrated pull-up resistors are used to pull-the I/O lines to either  $V_{CCA}$  or  $V_{CCB}$ . When OE goes low, the pull-up resistors are disabled. There is an nmos transistor that connects the A-port and B-port. In addition, each output has integrated an one-shot rising edge detector to turn on the pmos transistor within a short duration to improve the low-to-high transition.

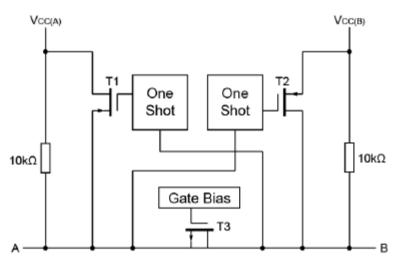


Figure 8: Architecture of LXS0104 I/O cell (one channel)

#### **Input Driver Requirements**

The rise  $(t_R)$  and fall  $(t_F)$  timing parameters of the open drain outputs depend on the magnitude of the pull-up resistors. In addition, the propagation times  $(t_{PD})$ , and maximum data rate depend on the impedance of the device that is connected to the translator. The timing parameters listed in the data sheet assume that the output impedance of the drivers connected to the translator is less than 50  $\Omega$ .

#### **Output Enable and Disable (OE)**

The LXS0104 has an Output Enable pin (OE) that enables the device by setting HIGH. Driving the Output Enable pin to a low logic level minimizes the power consumption of the device and set all I/Os in high-impedance OFF state. Normal translation operation occurs when the OE pin is equal to a logic high signal. The OE pin is referenced to the V<sub>CCA</sub> supply.

#### **Power Supply Guidelines**

During normal operation, supply voltage  $V_{CCA}$  must be less than or equal to  $V_{CCB}$ . The sequencing of the power supplies will not damage the device during the power up operation. For optimal performance,  $0.01\mu F$  to  $0.1\mu F$  decoupling capacitors should be used on the  $V_{CCA}$  and  $V_{CCB}$  power supply pins. Ceramic capacitors are a good design choice to filter and bypass any noise signals on the voltage lines to the ground plane of the PCB. The noise immunity will be maximized by placing the capacitors as close as possible to the supply and ground pins, along with minimizing the PCB connection traces.







# **Part Marking**

#### L Package

LXS01 04LE YYWWXX̄

YY: Date Code (Year)
WW: Date Code (Workweek)
1st X: Assembly Code
2nd X: Fab Code
Bar above 2nd "X" means Cu wire

## **GAB Package**

LXS0104 GABE YYWWXX

YY: Date Code (Year) WW: Date Code (Workweek) 1st X: Assembly Site Code 2nd X: Fab Site Code

## **ZB** Package



YY: Date Code (Year) WW: Date Code (Workweek) 1st X: Assembly Site Code 2nd X: Fab Site Code

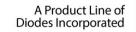
Bar above 2nd "X" means Cu wire

#### **ZMA Package**



xW: LXS0104ZMAE Y: Date Code (Year) W: Date Code (Workweek)

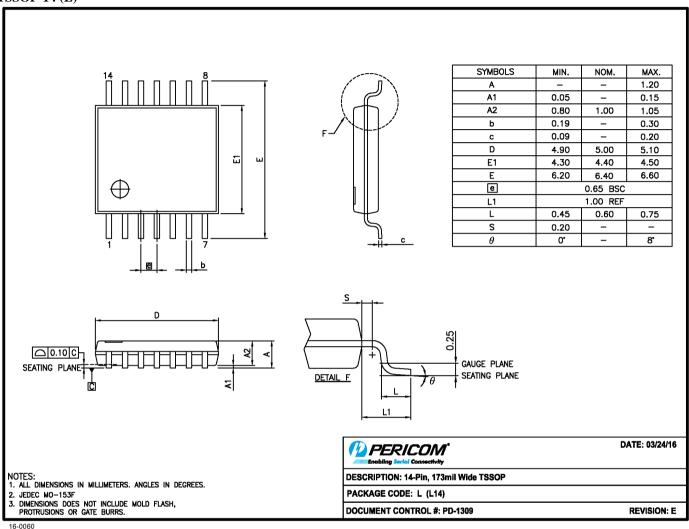




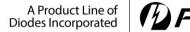


# **Packaging Mechanical**

## TSSOP-14 (L)

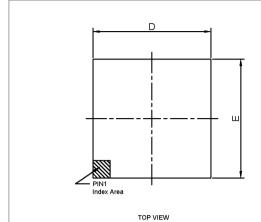


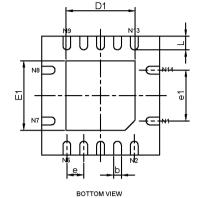




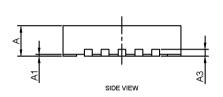


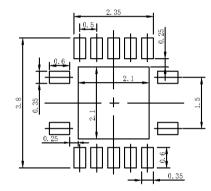
# **TQFN-14 (ZB)**





PKG.	PKG. DIMENSIONS(MM)					
SYMBOL	Min	Max				
Α	0.80	0.90				
A1	0.00	0.05				
A3	0.20	REF				
D	3.42	3.58				
E	3.42	3.58				
D1	1.95	2.15				
E1	1.95	2.15				
b	0.20	0.30				
е	0.50	TYP				
e1	1.50	TYP				
L	0.32	0.48				





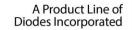
RECOMMENDED LAND PATTERN(unit:mm)

- Notes:
  1. Controlling dimensions in millimeters.
  2. Ref: JEDEC MO-220
  3.LAND PATTERN REFERENCE DIODES V-DFN3535-14 PACKAGE INFORMATION

PERICON : PROGRAM OF THE PROGRAM OF		DATE: 03/11/21		
DESCRIPTION: 14-Pin,	DESCRIPTION: 14-Pin, TQFN, 3.5*3.5			
PACKAGE CODE: ZB (	PACKAGE CODE: ZB (ZB14)			
DOCUMENT CONTRO:	#: PD-2154	REVISION: A		

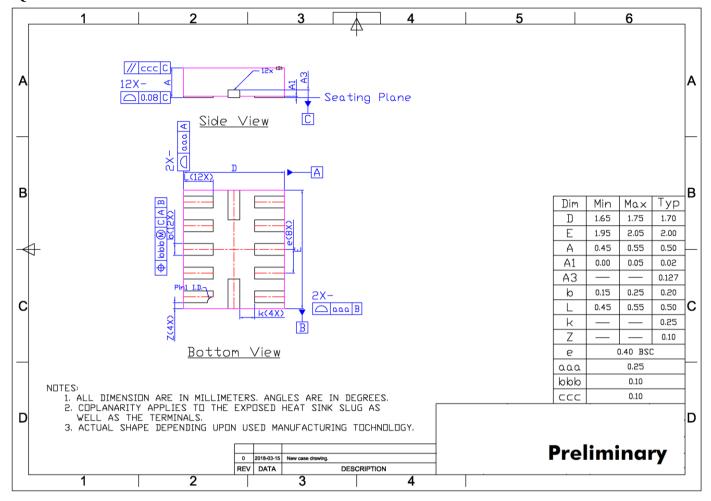
21-1377



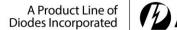




## XQFN-12

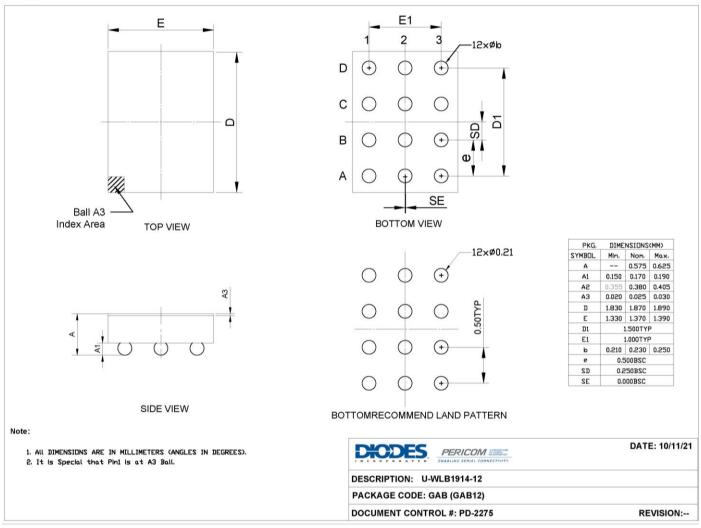








#### WLCSP-12



#### For latest package info.

Please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

# **Ordering Information**

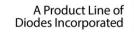
Part Number	Package Code	Package Description
LXS0104LEX	L	14-pin, TSSOP
LXS0104ZBEX	ZB	14-pin,TQFN 3.5mm x 3.5mm
LXS0104ZMAEX	ZMA	12-pin, XQFN 1.7mm x 2.0mm
LXS0104GABEX	GAB	12-ball, WLCSP

#### Notes:

- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- E = Pb-free and Green
- X suffix = Tape/Reel

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